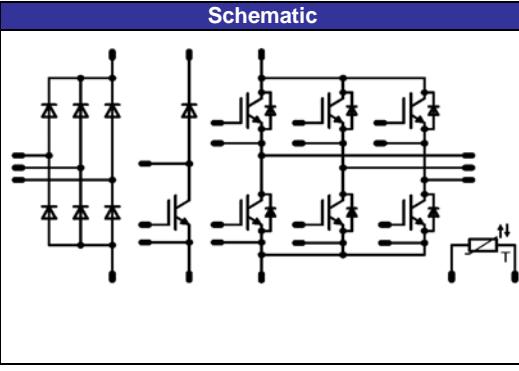


MiniSkiP® 3 PIM		600V/75A
<b>Features</b>		
<ul style="list-style-type: none"> <li>• IGBT3 technology for low saturation losses</li> <li>• Solderless spring contact mounting system</li> </ul>		
<b>Target Applications</b>		<b>Schematic</b>
<ul style="list-style-type: none"> <li>• Industrial motor drives</li> </ul>		
<b>Types</b>		
<ul style="list-style-type: none"> <li>• V23990-K242-A-PM</li> </ul>		

## Maximum Ratings

T<sub>j</sub>=25°C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
<b>D8,D9,D10,D11,D12,D13</b>				
Repetitive peak reverse voltage	V <sub>RRM</sub>		1600	V
DC forward current	I <sub>FAV</sub>	T <sub>j</sub> =T <sub>j</sub> max T <sub>h</sub> =80°C T <sub>c</sub> =80°C	69 93	A
Surge forward current	I <sub>FSM</sub>		700	A
I <sup>2</sup> t-value	I <sup>2</sup> t	t <sub>p</sub> =10ms T <sub>j</sub> =25°C	2450	A <sup>2</sup> s
Power dissipation per Diode	P <sub>tot</sub>	T <sub>j</sub> =T <sub>j</sub> max T <sub>h</sub> =80°C T <sub>c</sub> =80°C	77 117	W
Maximum Junction Temperature	T <sub>j</sub> max		150	°C

## T1,T2,T3,T4,T5,T6,T7

Collector-emitter break down voltage	V <sub>CE</sub>		600	V
DC collector current	I <sub>C</sub>	T <sub>j</sub> =T <sub>j</sub> max T <sub>h</sub> =80°C T <sub>c</sub> =80°C	70 92	A
Repetitive peak collector current	I <sub>Cpulse</sub>	t <sub>p</sub> limited by T <sub>j</sub> max	225	A
Turn off safe operating area		V <sub>CE</sub> ≤ 1200V, T <sub>j</sub> ≤ Top max	225	A
Power dissipation per IGBT	P <sub>tot</sub>	T <sub>j</sub> =T <sub>j</sub> max T <sub>h</sub> =80°C T <sub>c</sub> =80°C	126 191	W
Gate-emitter peak voltage	V <sub>GE</sub>		±20	V
Short circuit ratings	t <sub>SC</sub> V <sub>CC</sub>	T <sub>j</sub> ≤150°C V <sub>GE</sub> =15V	6 360	μs V
Maximum Junction Temperature	T <sub>j</sub> max		175	°C

## Maximum Ratings

$T_j=25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
<b>D1,D2,D3,D4,D5,D6,D7</b>				
Peak Repetitive Reverse Voltage	$V_{RRM}$	$T_j=25^\circ\text{C}$	600	V
DC forward current	$I_F$	$T_j=T_j\text{max}$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	55 72	A
Repetitive peak forward current	$I_{FRM}$	$t_p$ limited by $T_j\text{max}$	45	A
Power dissipation per Diode	$P_{tot}$	$T_j=T_j\text{max}$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	79 120	W
Maximum Junction Temperature	$T_j\text{max}$		175	$^\circ\text{C}$

## Thermal Properties

Storage temperature	$T_{stg}$		-40...+125	$^\circ\text{C}$
Operation temperature under switching condition	$T_{op}$		-40...+125	$^\circ\text{C}$

## Insulation Properties

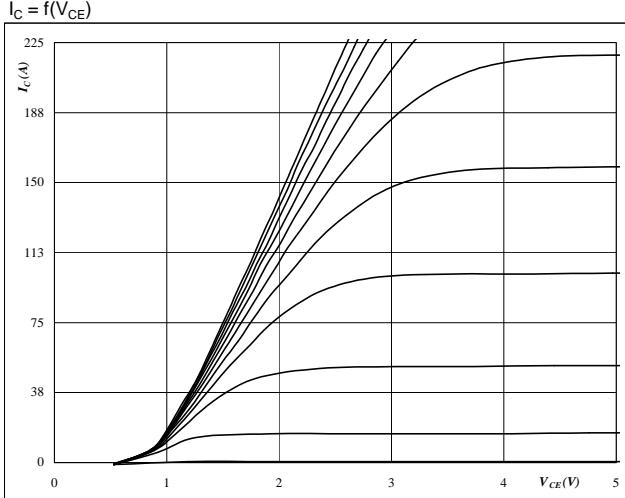
Insulation voltage	$V_{is}$	$t=2\text{s}$	DC voltage	4000	V
Creepage distance				min 12,7	mm
Clearance				min 12,7	mm

**Characteristic Values**

Parameter	Symbol	Conditions				Value			Unit	
			$V_{GE}$ [V] or $V_{GS}$ [V]	$V_r$ [V] or $V_{CE}$ [V] or $V_{DS}$ [V]	$I_c$ [A] or $I_F$ [A] or $I_D$ [A]	$T_J$	Min	Typ	Max	
<b>D8,D9,D10,D11,D12,D13</b>										
Forward voltage	$V_F$				35	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$	0,8	1,02 0,94	1,35	V
Threshold voltage (for power loss calc. only)	$V_{to}$				35	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		0,88 0,75		V
Slope resistance (for power loss calc. only)	$r_t$				35	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		4 6		$\text{m}\Omega$
Reverse current	$I_r$			1500		$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$			0,1 2	$\text{mA}$
Thermal resistance chip to heatsink per chip	$R_{thJH}$	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$						0,90		K/W
<b>T1,T2,T3,T4,T5,T6,T7</b>										
Gate emitter threshold voltage	$V_{GE(\text{th})}$	$V_{CE}=V_{GE}$			0,0012	$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$	5	5,8	6,5	V
Collector-emitter saturation voltage	$V_{CE(\text{sat})}$		15		75	$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$		1,54 1,75		V
Collector-emitter cut-off current incl. Diode	$I_{CES}$		0	612		$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$			0,1	$\text{mA}$
Gate-emitter leakage current	$I_{GES}$		±25	0		$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$			650	$\text{nA}$
Integrated Gate resistor	$R_{gint}$							4		$\Omega$
Turn-on delay time	$t_{d(\text{on})}$	$R_{\text{off}}=8 \Omega$ $R_{\text{on}}=8 \Omega$	±15	300	75	$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$		217 223		ns
Rise time	$t_r$					$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$		27 30		
Turn-off delay time	$t_{d(\text{off})}$					$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$		266 290		
Fall time	$t_f$					$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$		55 81		
Turn-on energy loss per pulse	$E_{\text{on}}$					$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$		1,58 2,07		mWs
Turn-off energy loss per pulse	$E_{\text{off}}$					$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$		1,79 2,24		
Input capacitance	$C_{ies}$	$f=1\text{MHz}$	0	25		$T_J=25^\circ\text{C}$		4700		pF
Output capacitance	$C_{oss}$							300		
Reverse transfer capacitance	$C_{rss}$							145		
Gate charge	$Q_{\text{Gate}}$		±15			$T_J=25^\circ\text{C}$		470		nC
Thermal resistance chip to heatsink per chip	$R_{thJH}$	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$						0,75		K/W
<b>D1,D2,D3,D4,D5,D6,D7</b>										
Diode forward voltage	$V_F$	$R_{\text{off}}=8 \Omega$	300	75		$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$	1	1,54 1,6	2,6	V
Peak reverse recovery current	$I_{RRM}$					$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$		63,45 74,57		A
Reverse recovery time	$t_{rr}$					$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$		58,2 262,4		ns
Reverse recovered charge	$Q_{rr}$					$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$		3,74 6,47		$\mu\text{C}$
Peak rate of fall of recovery current	$d(i_{\text{rec}})/dt$					$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$		3216 2350		$\text{A}/\mu\text{s}$
Reverse recovered energy	$E_{\text{rec}}$					$T_J=25^\circ\text{C}$ $T_J=150^\circ\text{C}$		0,74 1,33		mWs
Thermal resistance chip to heatsink per chip	$R_{thJH}$	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$						1,2		K/W
<b>Thermistor</b>										
Rated resistance	$R$					$T=25^\circ\text{C}$		1000		$\Omega$
Deviation of R100	$\Delta R/R$	$R_{100}=1670 \Omega$				$T=100^\circ\text{C}$	-3		3	%
R100	P					$T=100^\circ\text{C}$		1670,313		$\Omega$
Power dissipation constant						$T=25^\circ\text{C}$				$\text{mW/K}$
A-value	B(25/50)	Tol. %				$T=25^\circ\text{C}$		7,635*10-3		$1/\text{K}$
B-value	B(25/100)	Tol. %				$T=25^\circ\text{C}$		1,731*10-5		$1/\text{K}^2$
Vincotech NTC Reference								E		

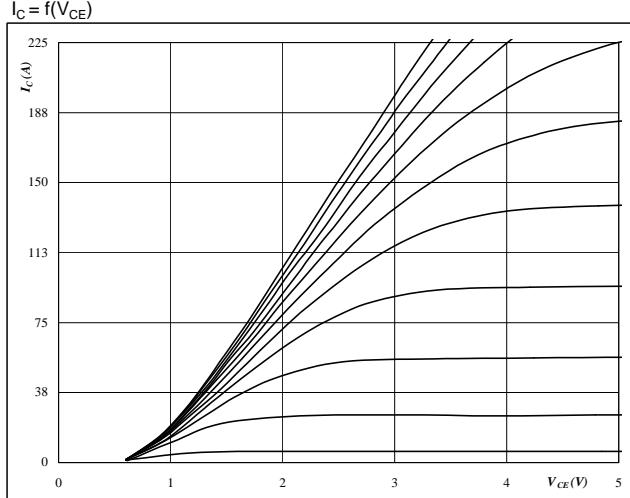
**T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7**

**Figure 1**  
Typical output characteristics  
 $I_C = f(V_{CE})$



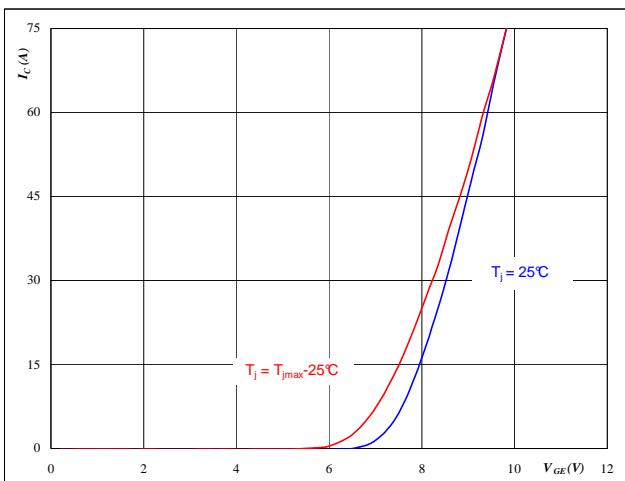
**At**  
 $t_p = 250 \mu s$   
 $T_j = 25^\circ C$   
 $V_{GE}$  from 7 V to 17 V in steps of 1 V

**Figure 2**  
Typical output characteristics  
 $I_C = f(V_{CE})$



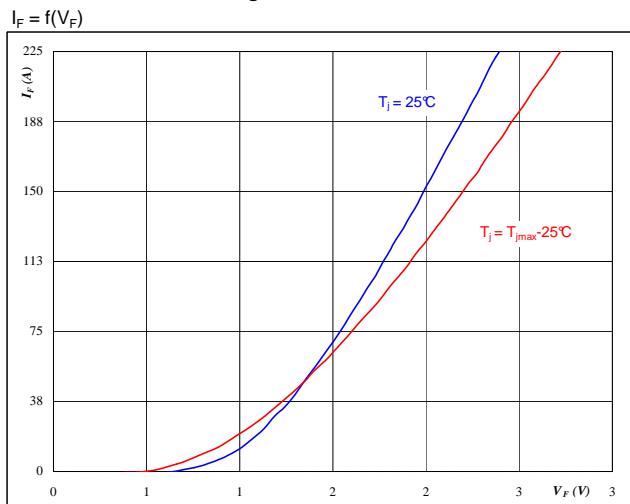
**At**  
 $t_p = 250 \mu s$   
 $T_j = 125^\circ C$   
 $V_{GE}$  from 7 V to 17 V in steps of 1 V

**Figure 3**  
Typical transfer characteristics  
 $I_C = f(V_{GE})$



**At**  
 $t_p = 250 \mu s$   
 $V_{CE} = 10 V$

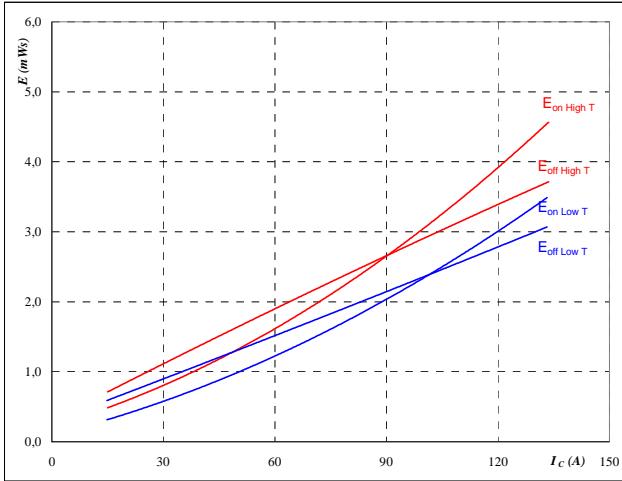
**Figure 4**  
Typical diode forward current as a function of forward voltage  
 $I_F = f(V_F)$



**At**  
 $t_p = 250 \mu s$

**T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7**
**Figure 5**
**T1,T2,T3,T4,T5,T6,T7 IGBT**
**Typical switching energy losses  
as a function of collector current**

$$E = f(I_C)$$

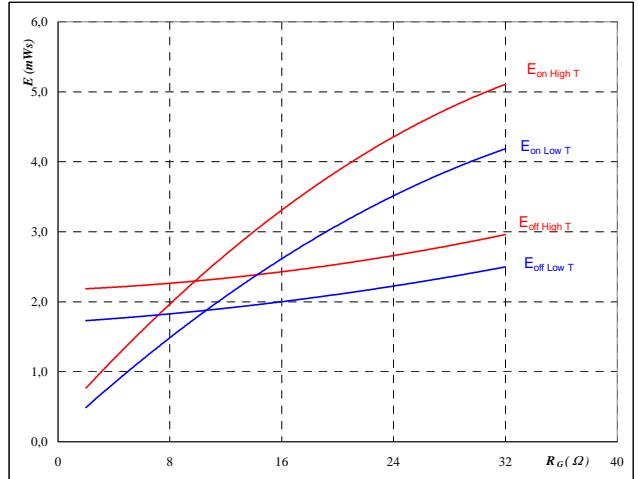


With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ C \\ V_{CE} &= 300 \quad V \\ V_{GE} &= \pm 15 \quad V \\ R_{gon} &= 8 \quad \Omega \\ R_{goff} &= 8 \quad \Omega \end{aligned}$$

**Figure 6**
**T1,T2,T3,T4,T5,T6,T7 IGBT**
**Typical switching energy losses  
as a function of gate resistor**

$$E = f(R_G)$$

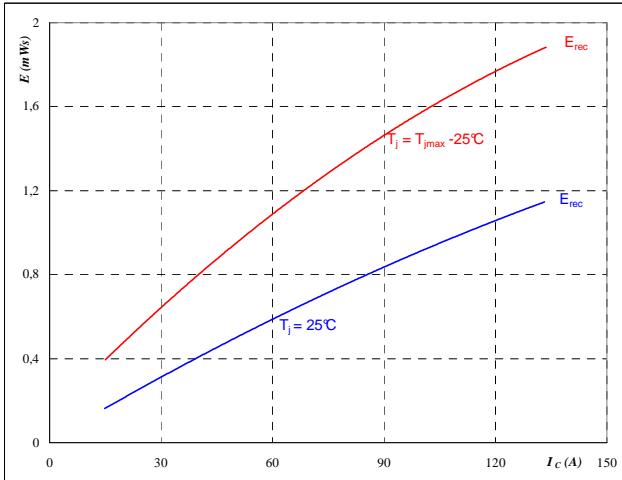


With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ C \\ V_{CE} &= 300 \quad V \\ V_{GE} &= \pm 15 \quad V \\ I_C &= 75 \quad A \end{aligned}$$

**Figure 7**
**T1,T2,T3,T4,T5,T6,T7 IGBT**
**Typical reverse recovery energy loss  
as a function of collector current**

$$E_{rec} = f(I_C)$$

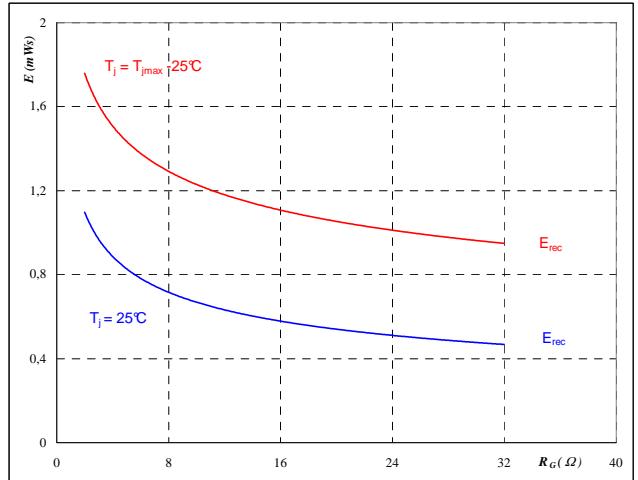


With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ C \\ V_{CE} &= 300 \quad V \\ V_{GE} &= \pm 15 \quad V \\ R_{gon} &= 8 \quad \Omega \end{aligned}$$

**Figure 8**
**T1,T2,T3,T4,T5,T6,T7 IGBT**
**Typical reverse recovery energy loss  
as a function of gate resistor**

$$E_{rec} = f(R_G)$$

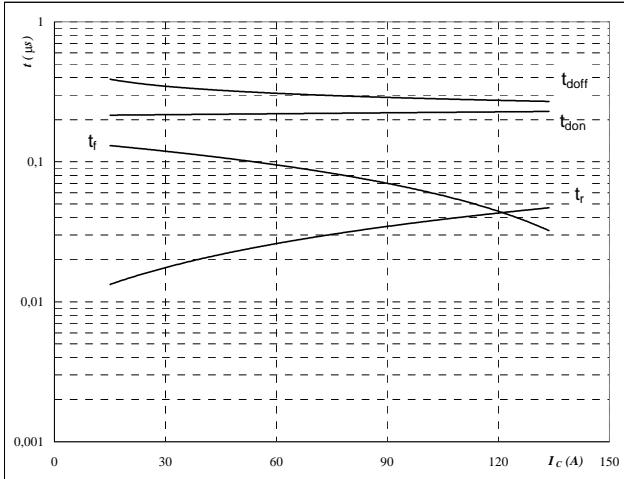


With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ C \\ V_{CE} &= 300 \quad V \\ V_{GE} &= \pm 15 \quad V \\ I_C &= 75 \quad A \end{aligned}$$

**T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7**
**Figure 9**
**T1,T2,T3,T4,T5,T6,T7 IGBT**
**Typical switching times as a function of collector current**

$t = f(I_C)$

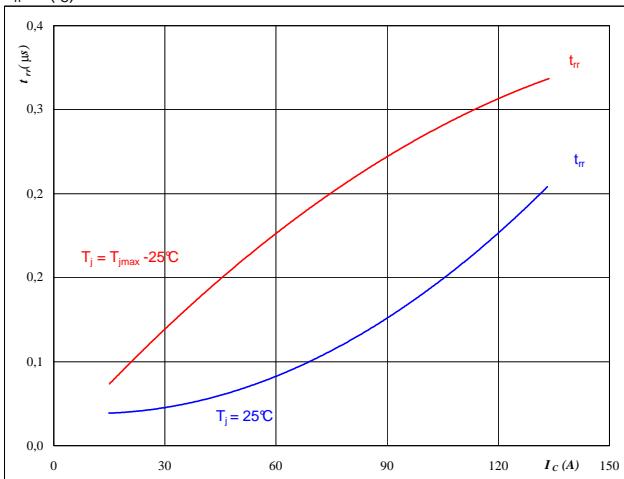


With an inductive load at

$$\begin{aligned} T_j &= 125 \quad ^\circ\text{C} \\ V_{CE} &= 300 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ R_{gon} &= 8 \quad \Omega \\ R_{goff} &= 8 \quad \Omega \end{aligned}$$

**Figure 11**
**D1,D2,D3,D4,D5,D6,D7 FWD**
**Typical reverse recovery time as a function of collector current**

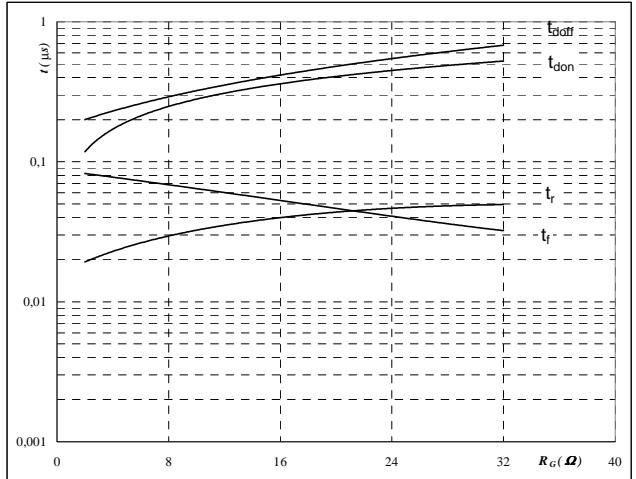
$t_{rr} = f(I_C)$


**At**

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{CE} &= 300 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ R_{gon} &= 8 \quad \Omega \end{aligned}$$

**Figure 10**
**T1,T2,T3,T4,T5,T6,T7 IGBT**
**Typical switching times as a function of gate resistor**

$t = f(R_G)$

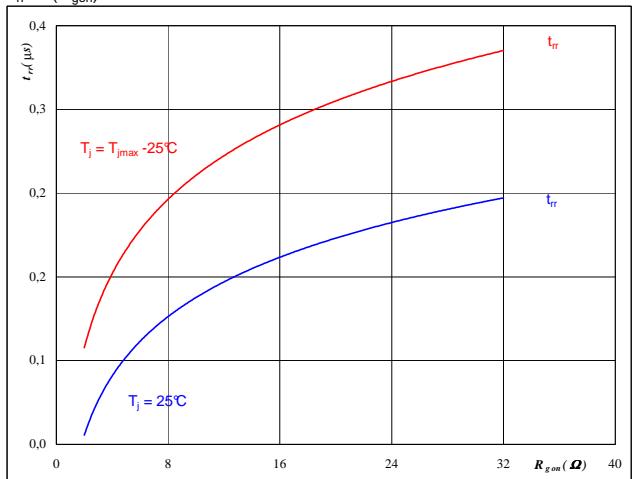


With an inductive load at

$$\begin{aligned} T_j &= 125 \quad ^\circ\text{C} \\ V_{CE} &= 300 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ I_C &= 75 \quad \text{A} \\ R_{goff} &= 8 \quad \Omega \end{aligned}$$

**Figure 12**
**D1,D2,D3,D4,D5,D6,D7 FWD**
**Typical reverse recovery time as a function of IGBT turn on gate resistor**

$t_{rr} = f(R_{gon})$


**At**

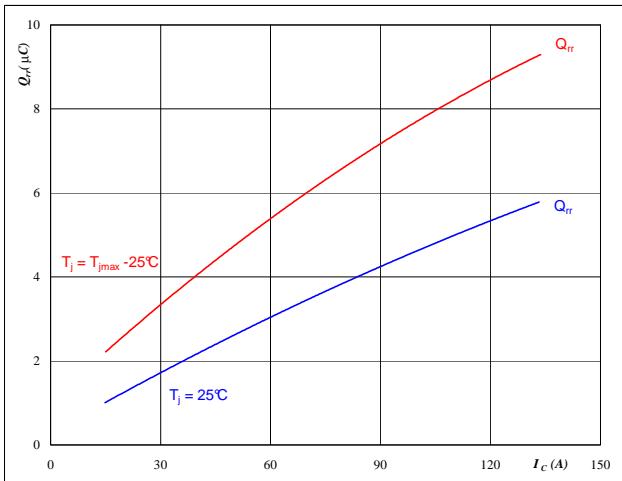
$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_R &= 300 \quad \text{V} \\ I_F &= 75 \quad \text{A} \\ V_{GE} &= \pm 15 \quad \text{V} \end{aligned}$$

**T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7**
**Figure 13**

D1,D2,D3,D4,D5,D6,D7 FWD

Typical reverse recovery charge as a function of collector current

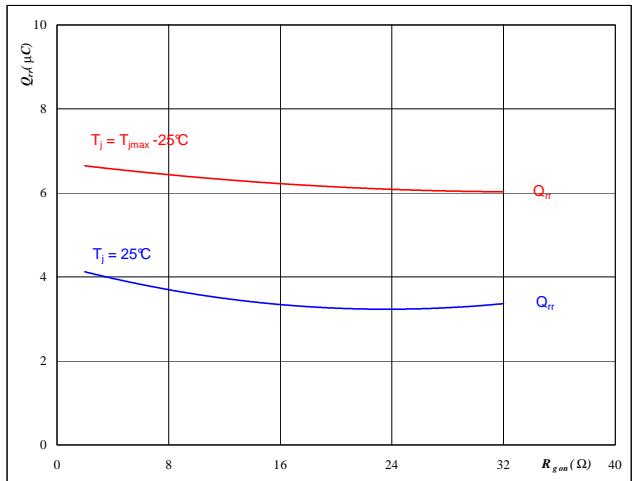
$$Q_{rr} = f(I_C)$$


**Figure 14**

D1,D2,D3,D4,D5,D6,D7 FWD

Typical reverse recovery charge as a function of IGBT turn on gate resistor

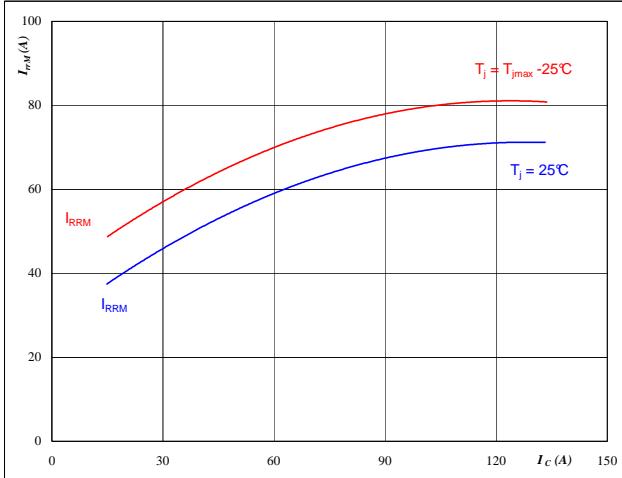
$$Q_{rr} = f(R_{gon})$$


**Figure 15**

D1,D2,D3,D4,D5,D6,D7 FWD

Typical reverse recovery current as a function of collector current

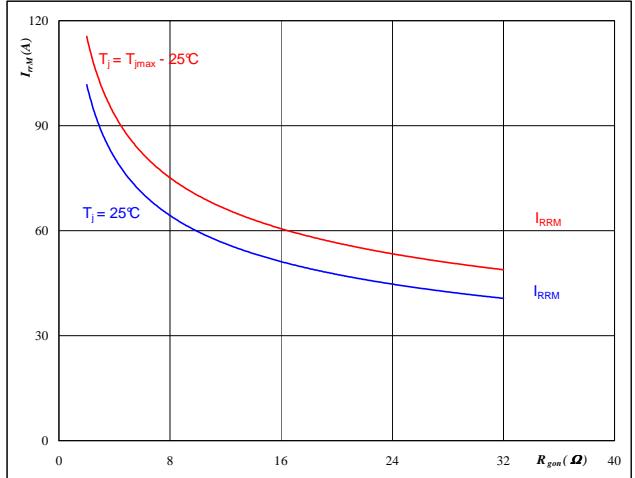
$$I_{RRM} = f(I_C)$$


**Figure 16**

D1,D2,D3,D4,D5,D6,D7 FWD

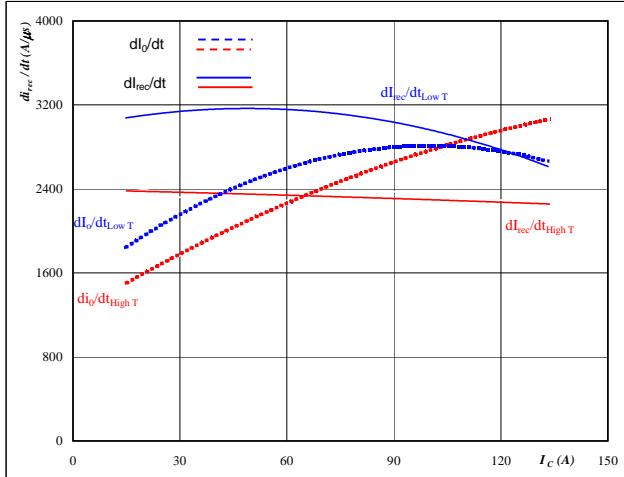
Typical reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RRM} = f(R_{gon})$$



**T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7**
**Figure 17**

Typical rate of fall of forward  
and reverse recovery current as a  
function of collector current  
 $dl_0/dt, dl_{rec}/dt = f(I_C)$

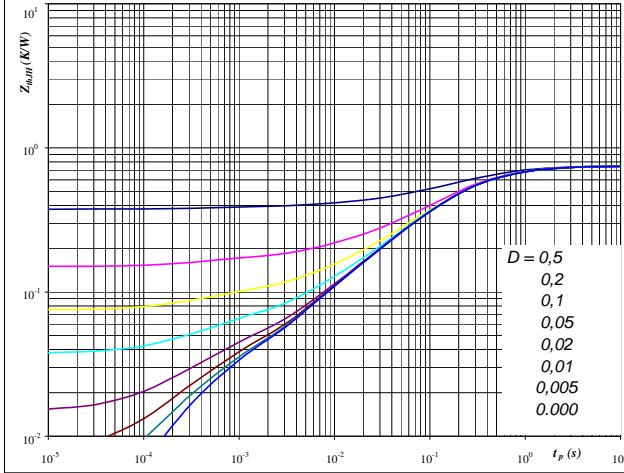

**At**

$T_j = 25/125$  °C  
 $V_{CE} = 300$  V  
 $V_{GE} = \pm 15$  V  
 $R_{gon} = 8$  Ω

**Figure 19**

IGBT transient thermal impedance  
as a function of pulse width

$$Z_{thJH} = f(t_p)$$


**At**

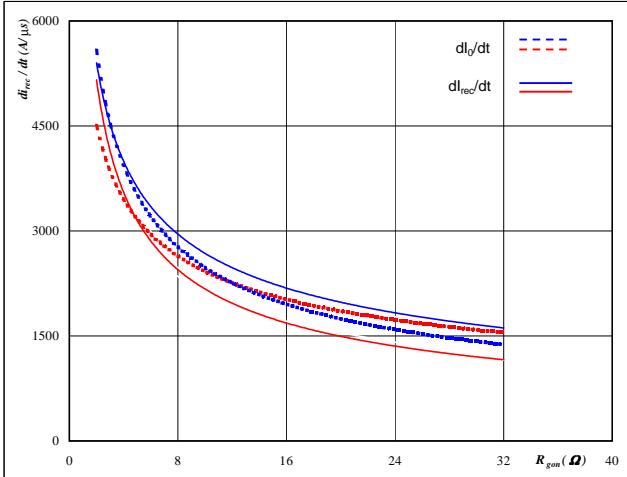
$D = t_p / T$   
 $R_{thJH} = 0.75$  K/W

**IGBT thermal model values**
**Thermal grease**

R (C/W)	Tau (s)
0,02	9,4E+00
0,12	1,1E+00
0,41	2,1E-01
0,14	4,0E-02
0,04	6,3E-03
0,02	4,0E-04

**Figure 18**

Typical rate of fall of forward  
and reverse recovery current as a  
function of IGBT turn on gate resistor  
 $dl_0/dt, dl_{rec}/dt = f(R_{gon})$

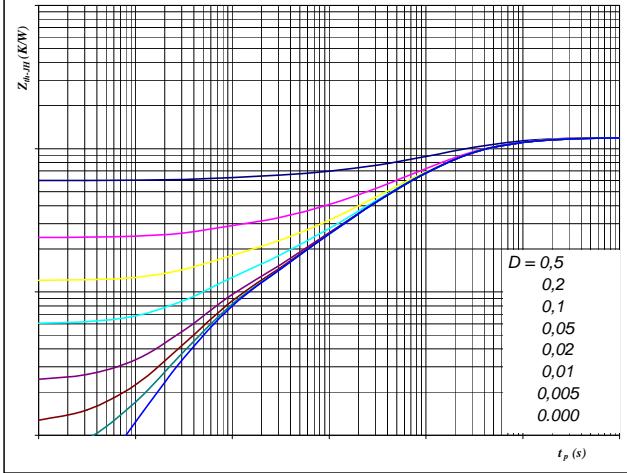

**At**

$T_j = 25/125$  °C  
 $V_R = 300$  V  
 $I_F = 75$  A  
 $V_{GE} = \pm 15$  V

**Figure 20**

FWD transient thermal impedance  
as a function of pulse width

$$Z_{thJH} = f(t_p)$$


**At**

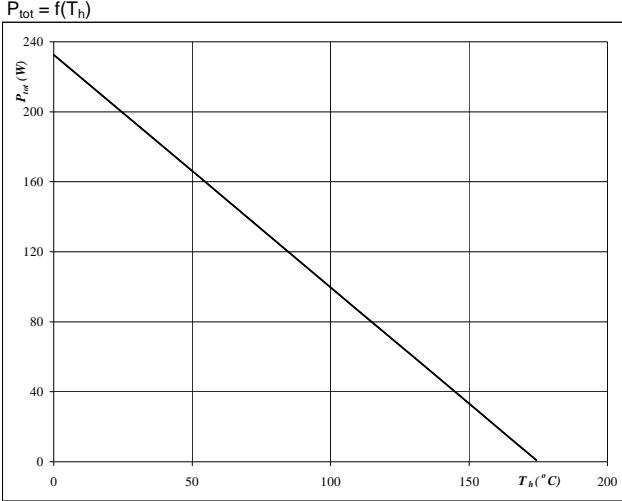
$D = t_p / T$   
 $R_{thJH} = 1.20$  K/W

**FWD thermal model values**
**Thermal grease**

R (C/W)	Tau (s)
0,02	9,9E+00
0,19	1,0E+00
0,54	1,8E-01
0,27	3,4E-02
0,11	6,0E-03
0,07	6,5E-04

**T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7**
**Figure 21**

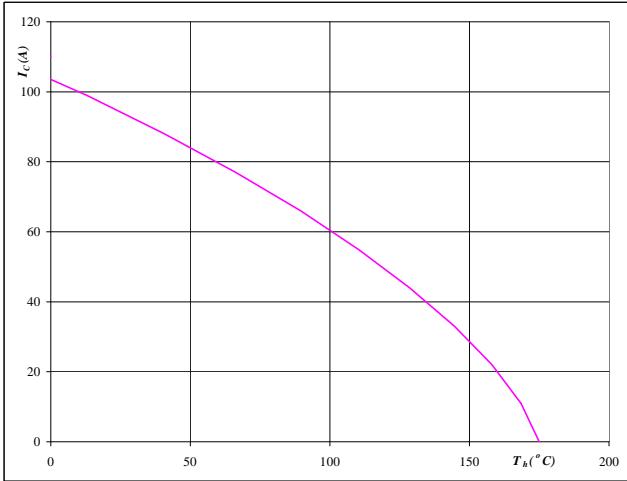
T1,T2,T3,T4,T5,T6,T7 IGBT

**Power dissipation as a function of heatsink temperature**  
 $P_{\text{tot}} = f(T_h)$ 

**At**

T<sub>j</sub> = 175 °C

**Figure 22**

T1,T2,T3,T4,T5,T6,T7 IGBT

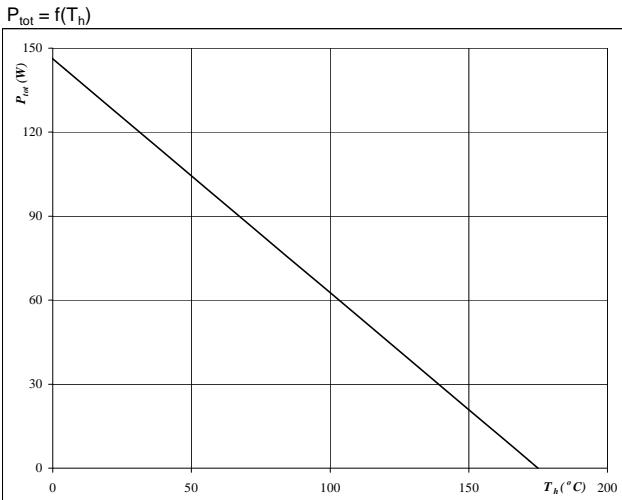
**Collector current as a function of heatsink temperature**  
 $I_C = f(T_h)$ 

**At**

T<sub>j</sub> = 175 °C

V<sub>GE</sub> = 15 V

**Figure 23**

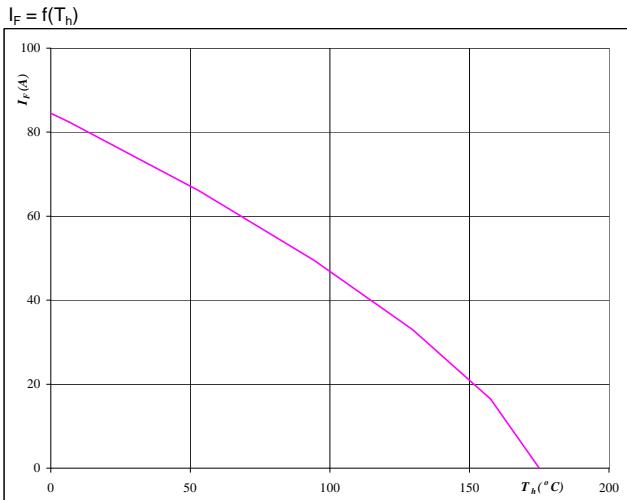
D1,D2,D3,D4,D5,D6,D7 FWD

**Power dissipation as a function of heatsink temperature**  
 $P_{\text{tot}} = f(T_h)$ 

**At**

T<sub>j</sub> = 175 °C

**Figure 24**

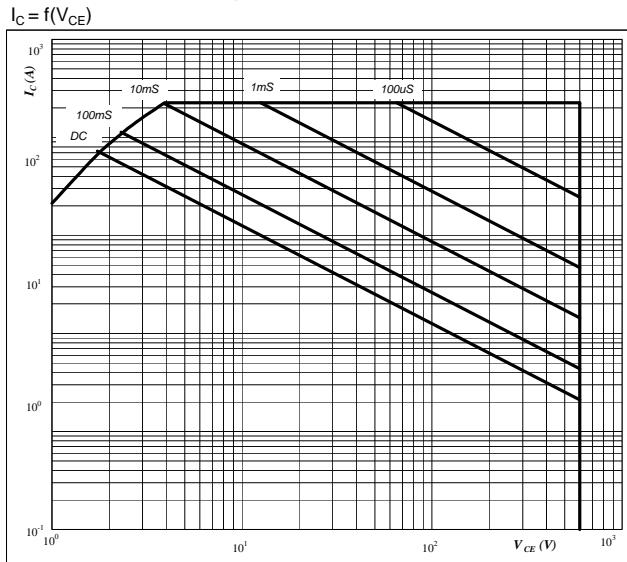
Output inverter FWD

**Forward current as a function of heatsink temperature**  
 $I_F = f(T_h)$ 

**At**

T<sub>j</sub> = 175 °C

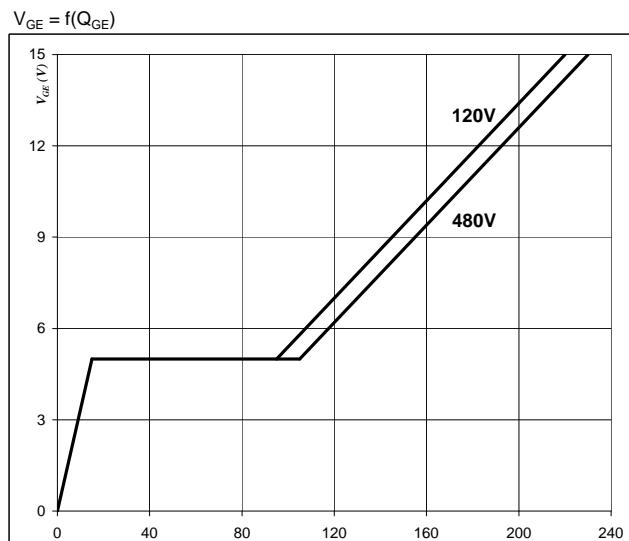
**T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7**

**Figure 25**  
**Safe operating area as a function  
of collector-emitter voltage**



**At**  
D = single pulse  
 $T_h = 80 \text{ } ^\circ\text{C}$   
 $V_{GE} = \pm 15 \text{ V}$   
 $T_j = T_{jmax} \text{ } ^\circ\text{C}$

**Figure 26**  
**Gate voltage vs Gate charge**



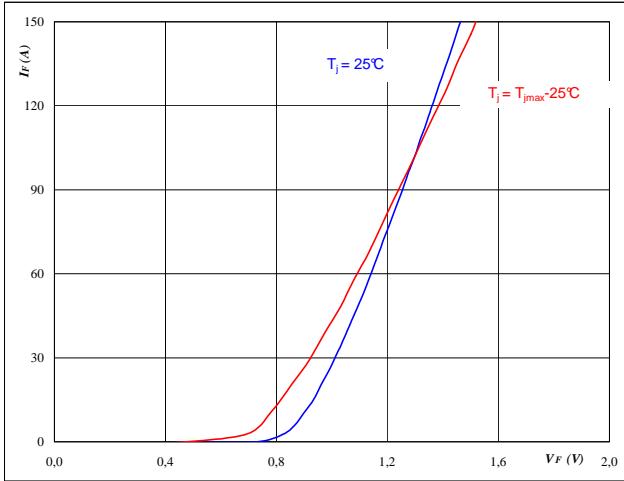
**At**  
 $I_C = 75 \text{ A}$

## D8,D9,D10,D11,D12,D13

**Figure 1** D8,D9,D10,D11,D12,D13 diode

Typical diode forward current as a function of forward voltage

$$I_F = f(V_F)$$



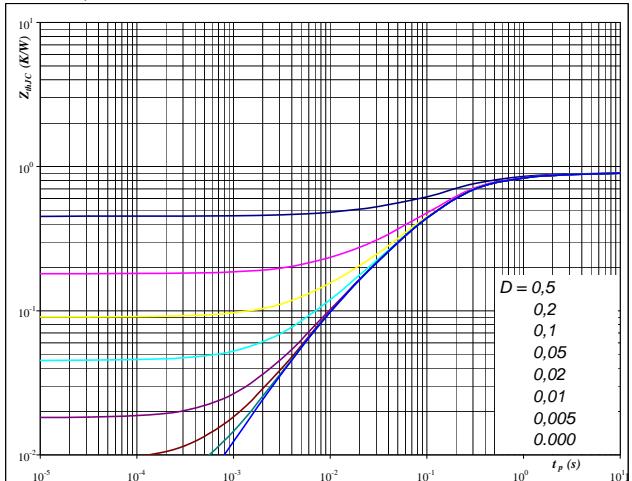
At

$$t_p = 250 \mu\text{s}$$

**Figure 2** D8,D9,D10,D11,D12,D13 diode

Diode transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At

$$D = t_p / T$$

$$R_{thJH} = 0.90 \text{ K/W}$$

**Figure 3** D8,D9,D10,D11,D12,D13 diode

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$



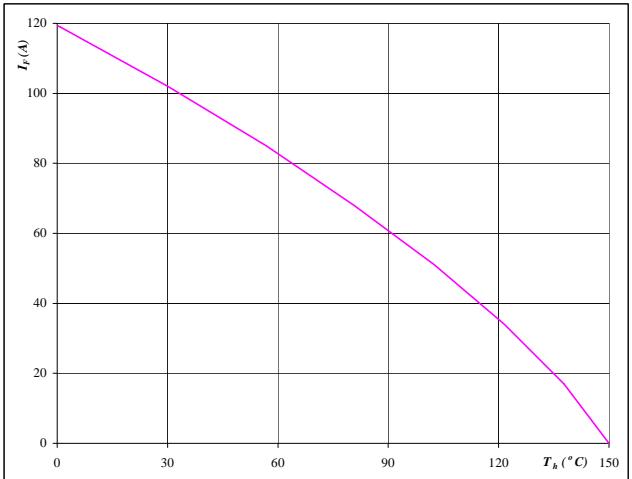
At

$$T_j = 150 ^\circ\text{C}$$

**Figure 4** D8,D9,D10,D11,D12,D13 diode

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$



At

$$T_j = 150 ^\circ\text{C}$$

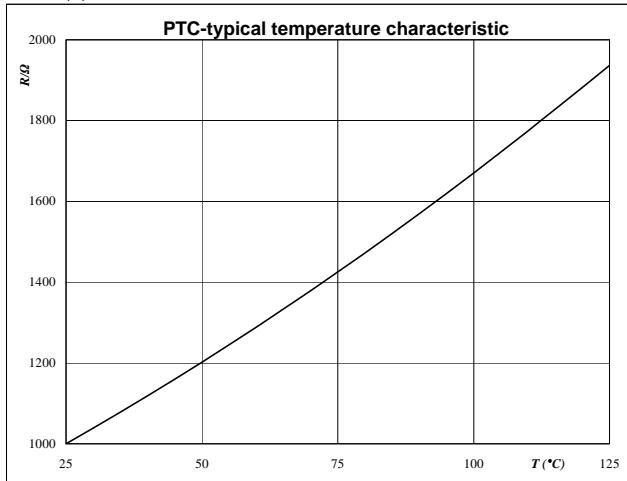
## Thermistor

**Figure 1**

Thermistor

**Typical PTC characteristic  
as a function of temperature**

$$R_T = f(T)$$



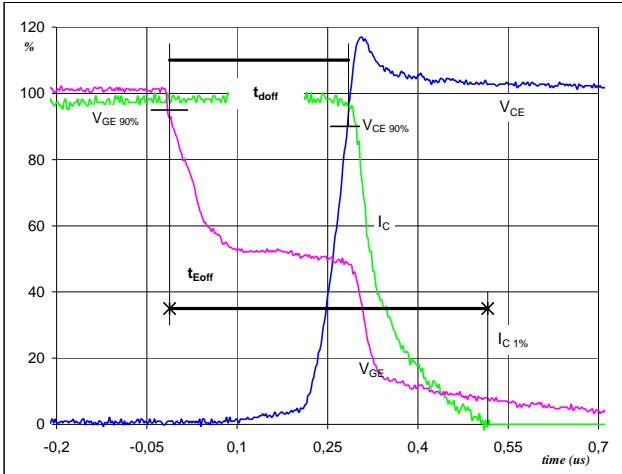
## Switching Definitions Output Inverter

**General conditions**

$T_j$	=	125 °C
$R_{gon}$	=	8 Ω
$R_{goff}$	=	8 Ω

**Figure 1**

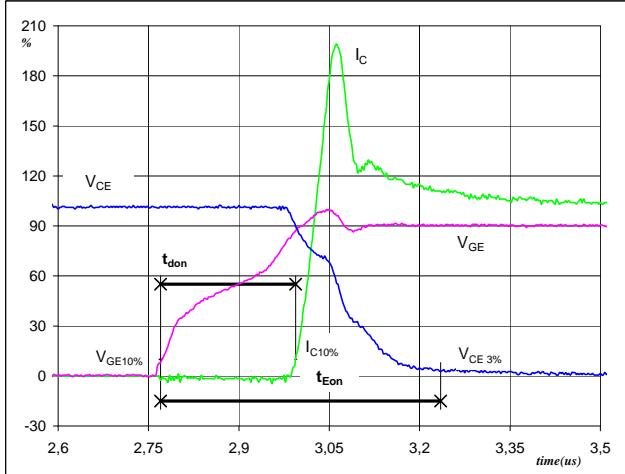
Output inverter IGBT  
Turn-off Switching Waveforms & definition of  $t_{doff}$ ,  $t_{Eoff}$   
( $t_{Eoff}$  = integrating time for  $E_{off}$ )



$V_{GE}(0\%) = -15$  V  
 $V_{GE}(100\%) = 15$  V  
 $V_C(100\%) = 300$  V  
 $I_C(100\%) = 75$  A  
 $t_{doff} = 0,29$  μs  
 $t_{Eoff} = 0,53$  μs

**Figure 2**

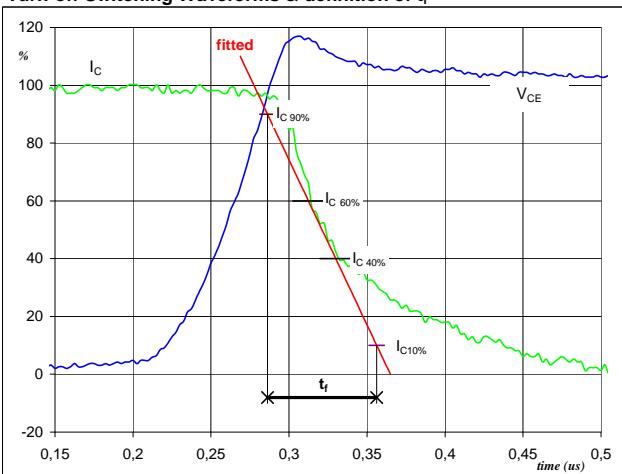
Output inverter IGBT  
Turn-on Switching Waveforms & definition of  $t_{don}$ ,  $t_{Eon}$   
( $t_{Eon}$  = integrating time for  $E_{on}$ )



$V_{GE}(0\%) = -15$  V  
 $V_{GE}(100\%) = 15$  V  
 $V_C(100\%) = 300$  V  
 $I_C(100\%) = 75$  A  
 $t_{don} = 0,22$  μs  
 $t_{Eon} = 0,47$  μs

**Figure 3**

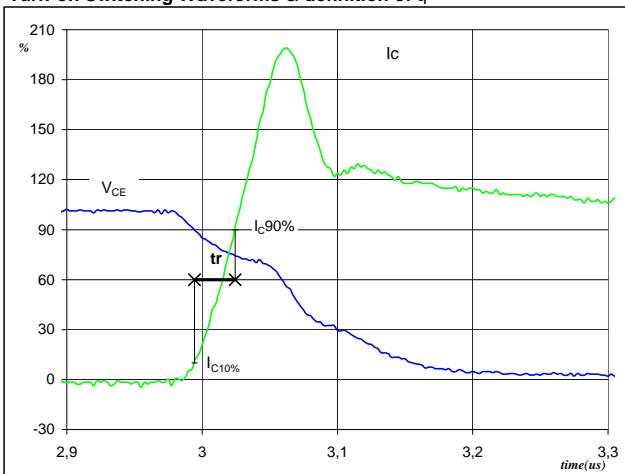
Output inverter IGBT  
Turn-off Switching Waveforms & definition of  $t_f$



$V_C(100\%) = 300$  V  
 $I_C(100\%) = 75$  A  
 $t_f = 0,08$  μs

**Figure 4**

Output inverter IGBT  
Turn-on Switching Waveforms & definition of  $t_r$

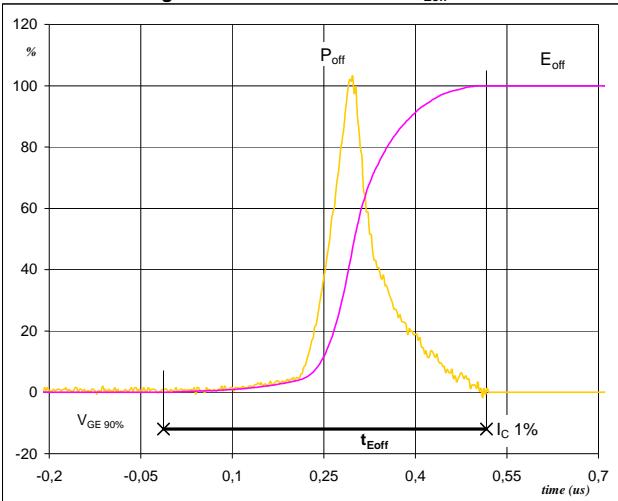


$V_C(100\%) = 300$  V  
 $I_C(100\%) = 75$  A  
 $t_r = 0,03$  μs

## Switching Definitions Output Inverter

**Figure 5**

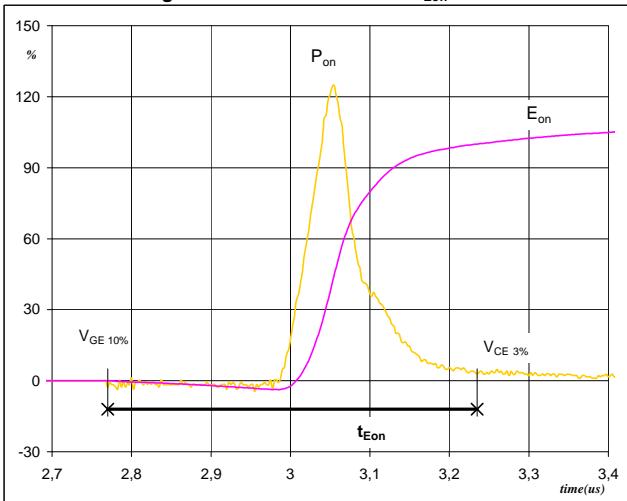
Output inverter IGBT

**Turn-off Switching Waveforms & definition of  $t_{Eoff}$** 


$$\begin{aligned} P_{off} (100\%) &= 22,50 \text{ kW} \\ E_{off} (100\%) &= 2,24 \text{ mJ} \\ t_{Eoff} &= 0,53 \mu\text{s} \end{aligned}$$

**Figure 6**

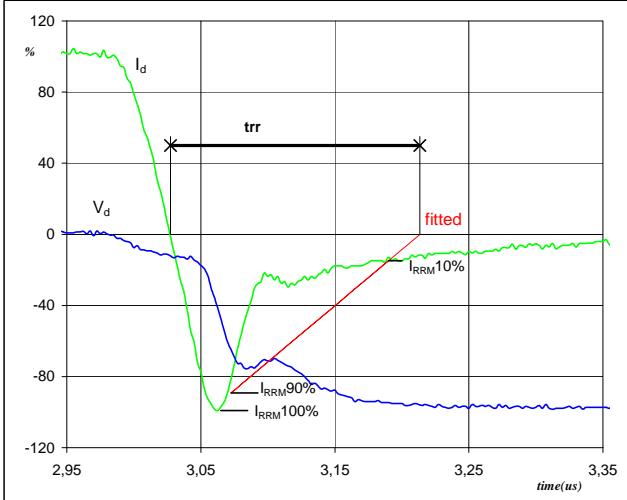
Output inverter IGBT

**Turn-on Switching Waveforms & definition of  $t_{Eon}$** 


$$\begin{aligned} P_{on} (100\%) &= 22,50 \text{ kW} \\ E_{on} (100\%) &= 2,07 \text{ mJ} \\ t_{Eon} &= 0,47 \mu\text{s} \end{aligned}$$

**Figure 7**

Output inverter FWD

**Turn-off Switching Waveforms & definition of  $t_{trr}$** 


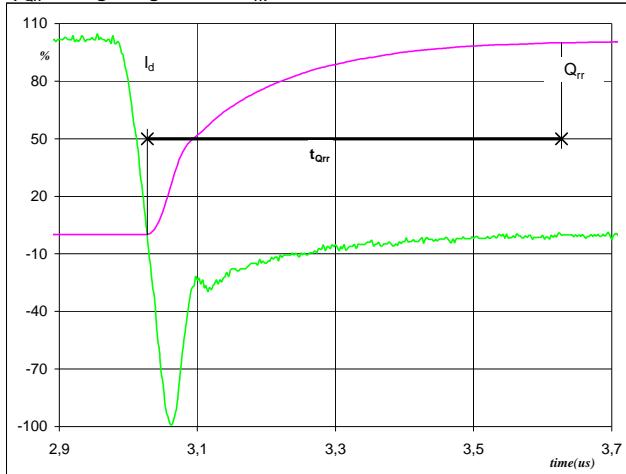
$$\begin{aligned} V_d (100\%) &= 300 \text{ V} \\ I_d (100\%) &= 75 \text{ A} \\ I_{RRM} (100\%) &= 75 \text{ A} \\ t_{trr} &= 0,26 \mu\text{s} \end{aligned}$$

## Switching Definitions Output Inverter

**Figure 8**

Output inverter FWD

**Turn-on Switching Waveforms & definition of  $t_{Qrr}$**   
 $(t_{Qrr} = \text{integrating time for } Q_{rr})$

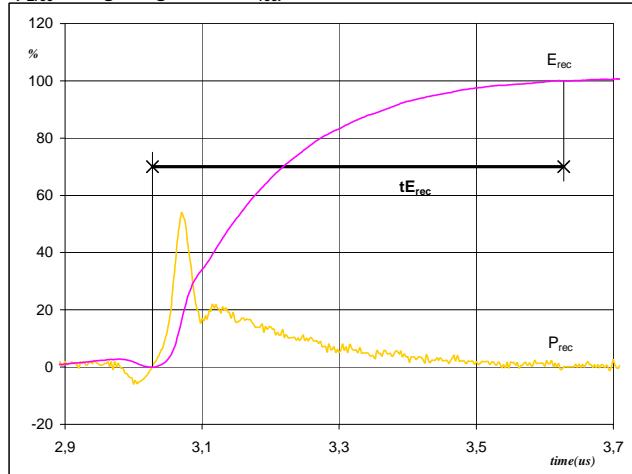


$I_d(100\%) = 75 \text{ A}$   
 $Q_{rr}(100\%) = 6,47 \mu\text{C}$   
 $t_{Qrr} = 0,60 \mu\text{s}$

**Figure 9**

Output inverter FWD

**Turn-on Switching Waveforms & definition of  $t_{Erec}$**   
 $(t_{Erec} = \text{integrating time for } E_{rec})$



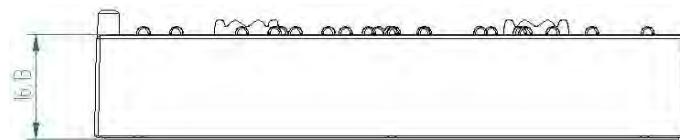
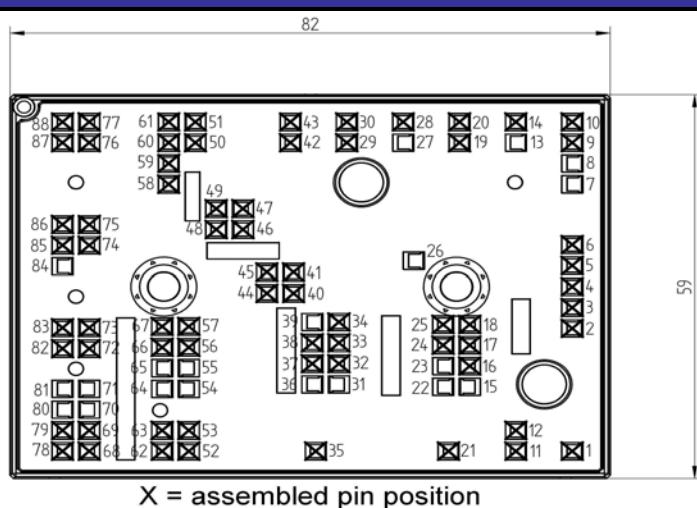
$P_{rec}(100\%) = 22,50 \text{ kW}$   
 $E_{rec}(100\%) = 1,33 \text{ mJ}$   
 $t_{Erec} = 0,60 \mu\text{s}$

### Ordering Code and Marking - Outline - Pinout

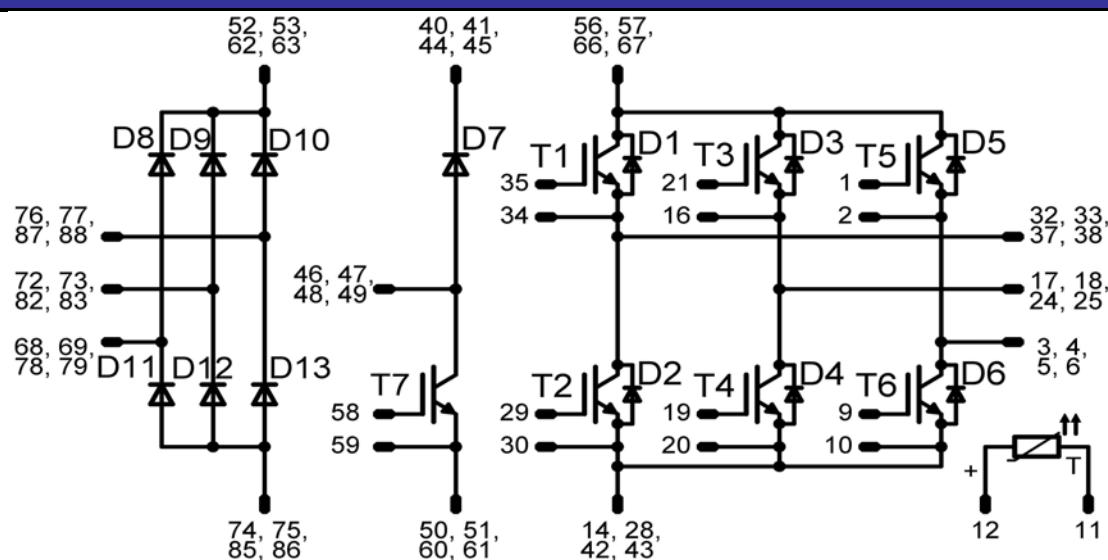
#### Ordering Code & Marking

Version	Ordering Code	in DataMatrix as	in packaging barcode as
with std lid (black V23990-K32-T-PM)	V23990-K242-A-/0A/-PM	K242A	K242A-/0A/
with std lid (black V23990-K32-T-PM) and P12	V23990-K242-A-/1A/-PM	K242A	K242A-/1A/
with thin lid (white V23990-K33-T-PM)	V23990-K242-A-/0B/-PM	K242A	K242A-/0B/
with thin lid (white V23990-K33-T-PM) and P12	V23990-K242-A-/1B/-PM	K242A	K242A-/1B/

#### Outline



#### Pinout



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